

## Electronic Supplementary Information

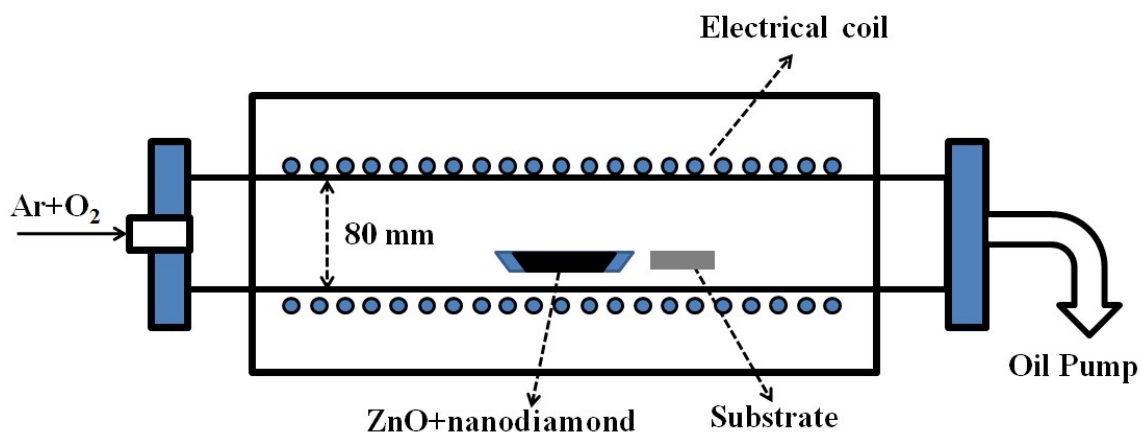
### Fabrication of ZnO Nanowires Array with Nanodiamond as Reductant

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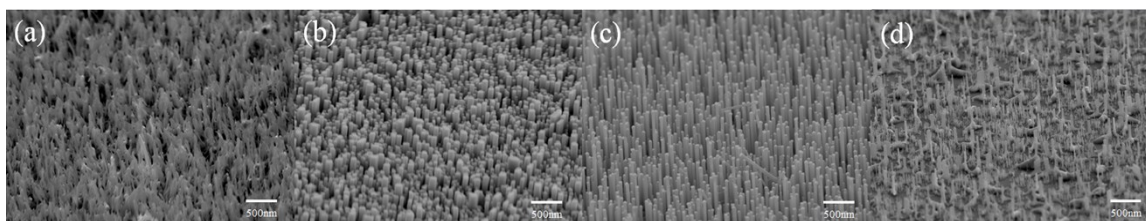
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**Fig. S1.** The schematic illustration of the chemical vapor deposition set-up for ZnO nanowire growth

(the mass of ZnO and diamond in this experiment were 0.21g, and 0.07g, respectively.)



**Fig. S2.** SEM images of obtained ZnO nanorods in 960 °C reaction with different reactants (a) ZnO+graphite, (b) ZnO+100nm nanodiamond, (c) ZnO+10nm nanodiamond, and (d) SEM image of obtained ZnO nanorods in 600°C reaction with ZnO+10nm nanodiamond without Au catalyst.

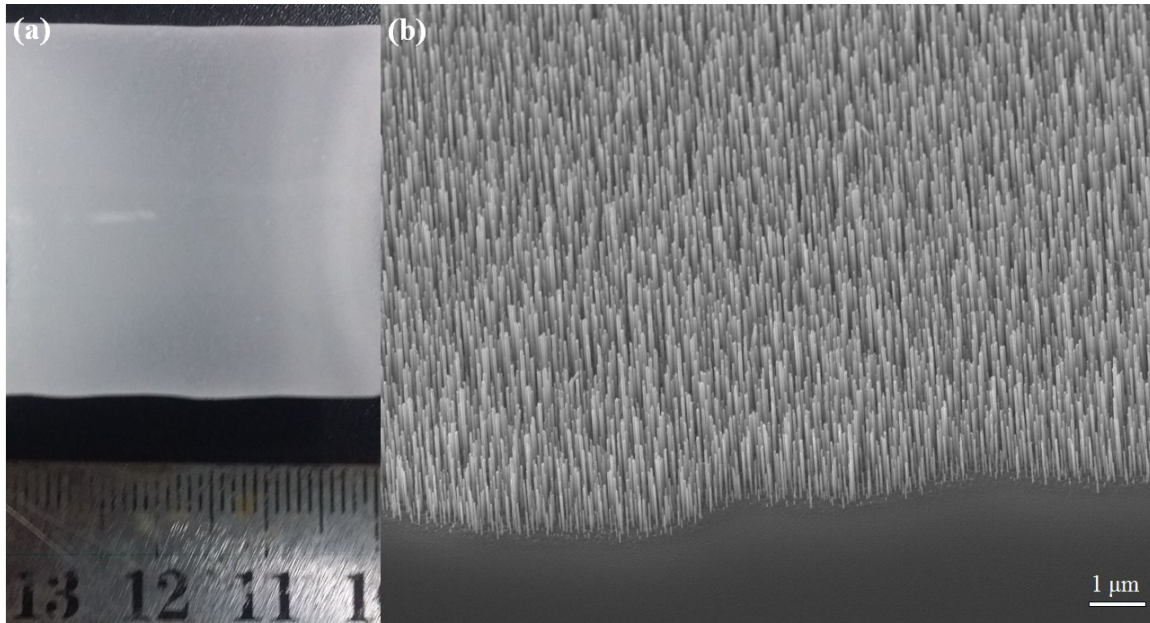


Fig. S3. The (a) optical and (b) low magnification SEM images of obtained ZnO nanorods in 600 °C reaction for 8 hours.

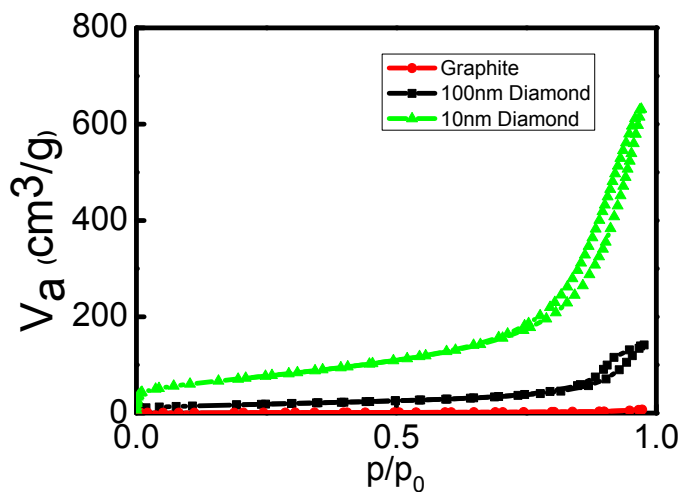


Fig. S4. The nitrogen adsorption–desorption isotherms of different allotropes of carbon

### Calculation of Debye characteristic temperature of 10 nm and 100nm nanodiamond

The Debye characteristic temperature of 10 nm and 100nm nanodiamond was calculated based on X-ray diffraction intensities by the methods introduced by X.S. Lu<sup>1</sup>.

Lu's method can be described as follows:

In the X-ray diffraction, the natural logarithm of the ratio of the calculated intensities to the observed intensities  $\ln(I_{calc} / I_{obs})$  should have the linear relationship with  $\sin^2 \theta / \lambda^2$ . The slope should be  $2B$ . In Debye theory of specific heat,  $B$  can be expressed as

$$B = (6h^2T / Mk\Theta_D^2)[\Phi(x) + x / 4]$$

Of which,  $x = \Theta_D / T$ .

If we assumed  $G = BMkT / 6h^2$ ,  $\Phi(x) + x / 4 = Gx^2$ . If we got the value of  $B$  from the X-ray diffraction data,

the G can be calculated. Then x can be determined by the graphic method. If we let  $y_1 = Gx$ ,  $y_2 = \Phi(x) + x/4$ , two curves can be obtained in the coordinate graph. The intersection of the two curves is the x value. Finally, Debye characteristic temperature can be calculated with the obtained x value.

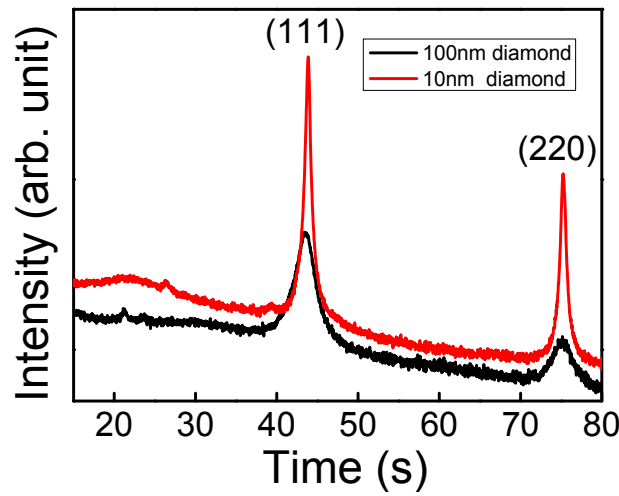


Fig. S5 The XRD diffraction pattern of 10nm diamond and 100nm diamond.

The X-ray diffraction results were shown in table S1.

Table S1. The raw data and calculation results

hkl	$\theta/^\circ\text{C}$	f	$ F ^2$	J	P	$I_{calc}$	$I_{obs}$	$\ln(I_{calc}/I_{obs})$	
111	10nm	43.398	3.125	312.5	8.178	8	20425	3587	0.755
	100nm	43.822	3.125	312.5	8.178	8	20425	50674	-0.395
220	10nm	75.090	2.028	263.2	2.815	12	8891.5	537	1.219
	100nm	75.228	2.028	263.2	2.815	12	8891.5	9512	-0.293

- (1) X-ray atomic scattering factor f (to  $\sin\theta/\lambda \text{ \AA}^{-1}$ ), can be calculated after looking up the table<sup>2</sup>.
- (2) The structure factor is calculated by the following equation<sup>2</sup>,

$$|F|^2 = FF^* = \left| \sum_m f_m \exp[-2\pi i r_m \cdot \mathbf{OG}] \right|^2$$

For diamond cell, m=8, there are 8 atoms in the unit cell. The position coordinates are  $000, \frac{1}{2}, \frac{1}{2}, 0, 0, \frac{1}{2}, \frac{1}{2}, \frac{1}{2}$

$\frac{1}{2}, \frac{1}{4}, \frac{1}{4}, \frac{1}{4}, \frac{3}{4}, \frac{3}{4}, \frac{1}{4}, \frac{1}{4}, \frac{3}{4}, \frac{3}{4}, \frac{3}{4}, \frac{1}{4}, \frac{3}{4}$ . Therefore, the calculation results should be  $|F_{(111)}|^2 = 32f_{(111)}^2$ ,

$$|F_{(220)}|^2 = 64f_{(220)}^2.$$

- (3) The expression of the angular factor J is

$$J = (1 + \cos^2 2\theta_B) / (\sin^2 \theta_B \cdot \cos \theta_B)$$

The value can be calculated by above equation as well as looking up the table<sup>1</sup>.

- (4) The multiplicity factor P can be found in the table through the crystal surface index (hkl).

(5) The calculation intensities  $I_{calc}^2$  can be calculated as

$$I_{calc} = KN_0^2VFF^*$$

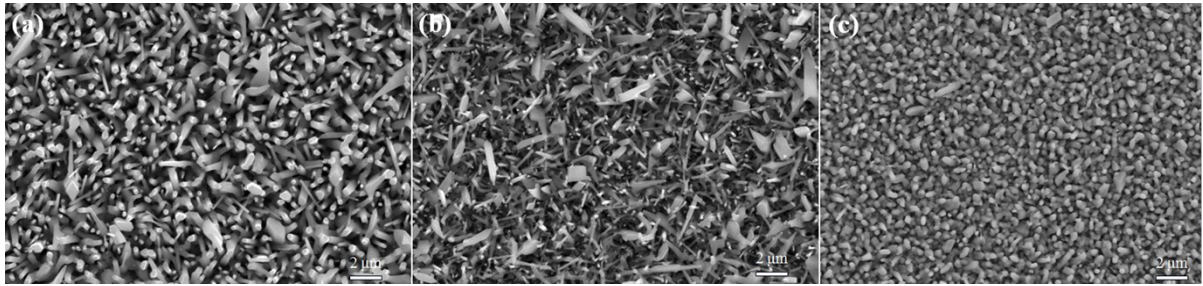
In which, K is a scaling factor;  $N_0^2V$  is the number of unit cells that can produce diffraction.

The calculated values of the above quantities are shown in table S1.

From the linear relationship between  $\ln(I_{calc} / I_{obs})$  and  $\sin^2 \theta / \lambda^2$ , B can be calculated. Then, G can be calculated with the constant parameters (atom mass  $1.66053 \times 10^{-24}$  g,  $k = 1.38062 \times 10^{-23}$  J · K,  $h = 6.62620 \times 10^{-34}$  J · s). After G was obtained, x can be determined by the graphic method. As we know  $\Theta_D = x \cdot T$ , the Debye characteristic temperature can be calculated.

**Table S2.** The Debye temperature of nanodiamond and graphite

Average diameter	B/nm <sup>2</sup>	T/C	G	x	$\Theta_D$ /K
10nm	0.03698	20	0.95868	1.002	304
100nm	0.008219	20	0.213	2.166	646



**Fig. S6** The SEM images of ZnO nanostructures obtained in (a)Si, (b)SiO<sub>2</sub>, and (c)FTO substrates

## REFERENCES

1. P. W. Chen, S. R. Yun, F. L. Huang, Y. S. Ding and Q. Chen, *Chinese J of High Pressure Phys*, 2001, **15**, 32-38.
2. B. D. Cullity and J. W. Weymouth, *Elements of x-ray diffraction*, Addison-Wesley Pub. Co.